## Notice of References Cited Application/Control No. 10/029,149 Examiner Philip J. Chea Applicant(s)/Patent Under Reexamination KOCH ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,138,139 A	10-2000	Beck et al.	709/202
	В	US-6,141,537 A	10-2000	Takahari, Kunio	455/66.1
	O	US-6,342,901 B1	01-2002	Adler et al.	715/700
	۵	US-2002/0023230 A1	02-2002	Bolnick et al.	713/202
	Е	US-2002/0065881 A1	05-2002	Mansikkaniemi et al.	709/204
	F	US-2002/0063732 A1	05-2002	Mansikkaniemi et al.	345/733
	G	US-6,466,236 B1	10-2002	Pivowar et al.	715/835
	Н	US-6,463,463 B1	10-2002	Godfrey et al.	709/206
	-	US-			
	J	US-			·
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	σ					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.